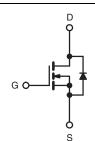


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	600				
$R_{DS(on)}\left(\Omega\right)$	V _{GS} = 10 V 4.4				
Q _g (Max.) (nC)	18				
Q _{gs} (nC)	3.0				
Q _{gd} (nC)	8.9				
Configuration	Single				





N-Channel MOSFET

FEATURES

- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- · For Automatic Insertion
- End Stackable
- · Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The 4 pin DIP package is a low cost machine-insertable case style which can be stacked in multiple combinations on standard 0.1" pin centers. The dual drain serves as a thermal link to the mounting surface for power dissipation levels up to 1 W.

ORDERING INFORMATION			
Package	HVMDIP		
Lead (Pb)-free	IRFDC20PbF		
Lead (Fb)-liee	SiHFDC20-E3		
SnPb	IRFDC20		
SIIF D	SiHFDC20		

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	600	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	$T_A = 25 ^{\circ}\text{C}$ $T_A = 100 ^{\circ}\text{C}$	- I _D	0.32		
Continuous Drain Current		T _A = 100 °C		0.20	Α	
Pulsed Drain Current ^a			I _{DM}	2.6		
Linear Derating Factor				0.0083	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	50	mJ	
Repetitive Avalanche Current ^a			I _{AR}	0.32	Α	
Repetitive Avalanche Energy ^a			E _{AR}	0.10	mJ	
Maximum Power Dissipation	T _A = 25 °C		P _D	1.0	W	
Peak Diode Recovery dV/dtc			dV/dt	3.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		-	300 ^d		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 54 mH, R_g = 25 Ω , I_{AS} = 1.3 A (see fig. 12).
- c. $I_{SD} \le 4.4$ A, $dI/dt \le 90$ A/ μ s, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.
- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply

IRFDC20, SiHFDC20

Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum Junction-to-Ambient	R_{thJA}	=	120	°C/W	

PARAMETER	SYMBOL	TES	MIN.	TYP.	MAX.	UNIT	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		600	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.88	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	V _{GS} = ± 20 V	-	-	± 100	nA
Zava Cata Valtaria Brain Commant	I _{DSS}	V _{DS} =	V _{DS} = 600 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current		V _{DS} = 480V	, V _{GS} = 0 V, T _J = 125 °C	-	-	250	μΑ
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 0.19 A ^b	-	-	4.4	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 1.3 A ^b	1.4	-	-	S
Dynamic		•					
Input Capacitance	C _{iss}		$V_{GS} = 0 V$,		350	-	
Output Capacitance	Coss	1	$V_{DS} = 25 \text{ V},$	-	48	-	pF
Reverse Transfer Capacitance	C _{rss}	f = 1	f = 1.0 MHz, see fig. 5		8.6	-	1
Total Gate Charge	Qg			-	-	18	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 2.0 \text{ A}, V_{DS} = 360 \text{ V},$ see fig.6 and 13 ^b	-	-	3.0	
Gate-Drain Charge	Q_{gd}		goo ngio ama io	-	-	8.9	
Turn-On Delay Time	t _{d(on)}	$V_{DD} = 300 \text{ V}, I_D = 2.0 \text{ A},$ $R_g = 18 \Omega, R_D = 150 \Omega,$ see fig. 10^b		-	10	-	- ns
Rise Time	t _r			-	23	-	
Turn-Off Delay Time	t _{d(off)}			-	30	-	
Fall Time	t _f			-	25	-	
Internal Drain Inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.0	-	nU
Internal Source Inductance	L _S			-	6.0	-	- nH
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET sym showing the	MOSFET symbol showing the		-	0.32	A
Pulsed Diode Forward Current ^a	I _{SM}	integral reverse p - n junction diode		-	-	2.6	
Body Diode Voltage	V_{SD}	T _J = 25 °C,	$I_S = 0.32 \text{ A}, V_{GS} = 0 \text{ V}^b$	-	-	1.6	V
Body Diode Reverse Recovery Time	t _{rr}	T _ 25 °C 1	- 2.0.4. dl/dt - 100.4/::ch	-	290	580	ns
Body Diode Reverse Recovery Charge	Q _{rr}	$T_J = 25 ^{\circ}\text{C}, I_F = 2.0 \text{A}, \text{dI/dt} = 100 \text{A/}\mu\text{s}^b$		-	0.67	1.3	μС
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dominated by L _S and L _D)					L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width \leq 300 $\mu s;$ duty cycle \leq 2 %





TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

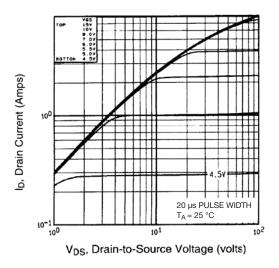


Fig. 1 - Typical Output Characteristics, T_A = 25 °C

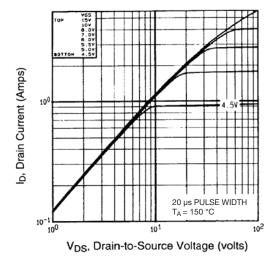


Fig. 2 - Typical Output Characteristics, T_A = 150 °C

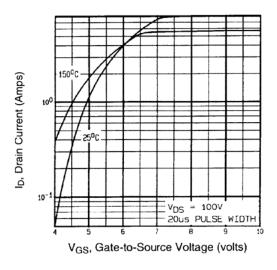


Fig. 3 - Typical Transfer Characteristics

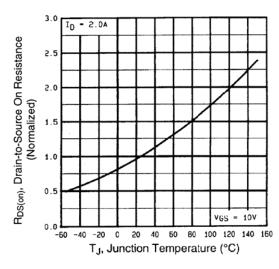


Fig. 4 - Normalized On-Resistance vs. Temperature



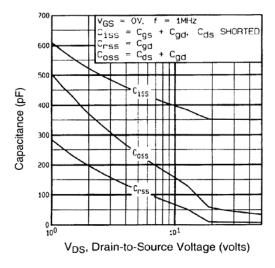


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

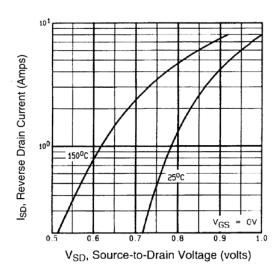


Fig. 7 - Typical Source-Drain Diode Forward Voltage

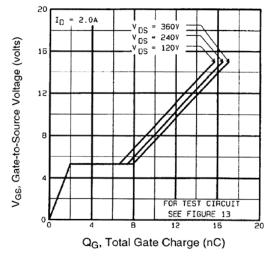


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

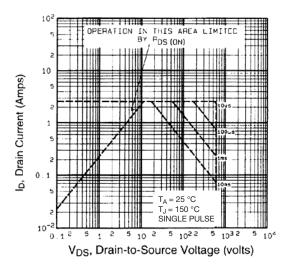


Fig. 8 - Maximum Safe Operating Area





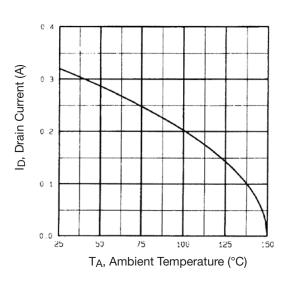


Fig. 9 - Maximum Drain Current vs. Ambient Temperature

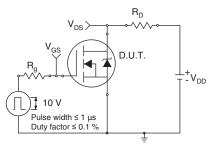


Fig. 10a - Switching Time Test Circuit

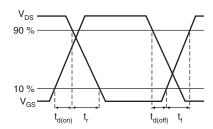


Fig. 10b - Switching Time Waveforms

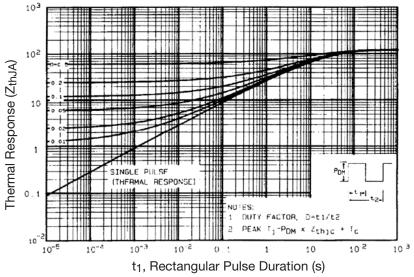


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

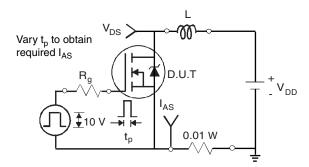


Fig. 12a - Unclamped Inductive Test Circuit

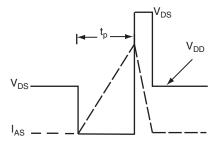


Fig. 12b - Unclamped Inductive Waveforms



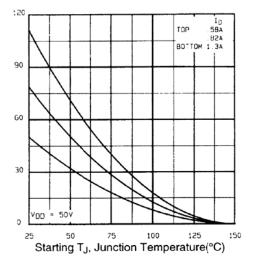


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

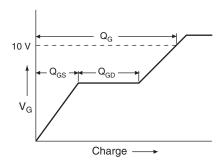


Fig. 13a - Basic Gate Charge Waveform

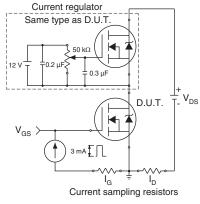
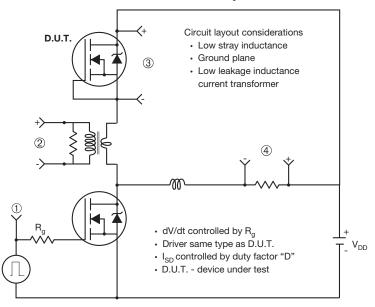


Fig. 13b - Gate Charge Test Circuit





Peak Diode Recovery dV/dt Test Circuit



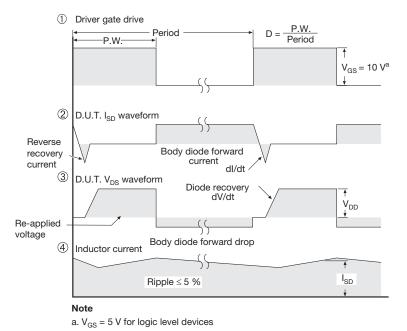
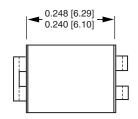
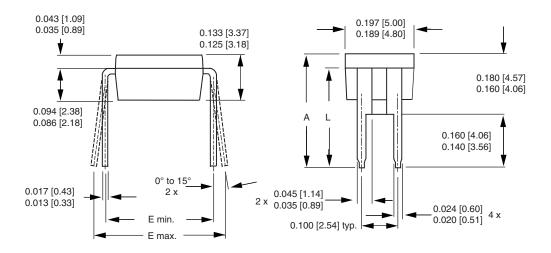


Fig. 14 - For N-Channel

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HVM DIP (High voltage)





	INCHES		MILLIMETERS		
DIM.	MIN.	MAX.	MIN.	MAX.	
Α	0.310	0.330	7.87	8.38	
Е	0.300	0.425	7.62	10.79	
L	0.270	0.290	6.86	7.36	

ECN: X10-0386-Rev. B, 06-Sep-10

DWG: 5974

Note

1. Package length does not include mold flash, protrusions or gate burrs. Package width does not include interlead flash or protrusions.

Document Number: 91361 Revision: 06-Sep-10



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